

APPROVAL SHEET

Type : Multilayer Chip Antenna
Part No. : ALA931C5

	Check	Consent	Approval



Amotech	Written	Checked		Approved
	 조경희	 이경희	 이경희	 조경희
	12/18	12/18.	12/18	12/18

2007. 2. 7

AMOTECH Co., Ltd.

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1. Revision Record

Date	Title	Content	Remark
2006.12.18		New drawing up	

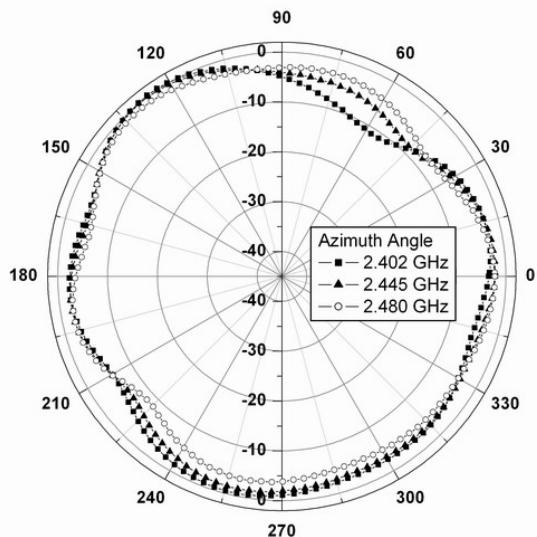
2. Specifications

2.1 Electrical specifications

No	Item	Spec.	Remark
1	Frequency Range	2400~2500	ISM Band
2	VSWR	Max. 3.0:1 @3285±45 MHz	On manual jig
3	Radiation Gain	Max. 0 dBi @azimuth co-pol.	Measured after matching on testboard
4	Radiation Pattern	Omni-directional	
5	Impedance	Nominal 50 Ω	



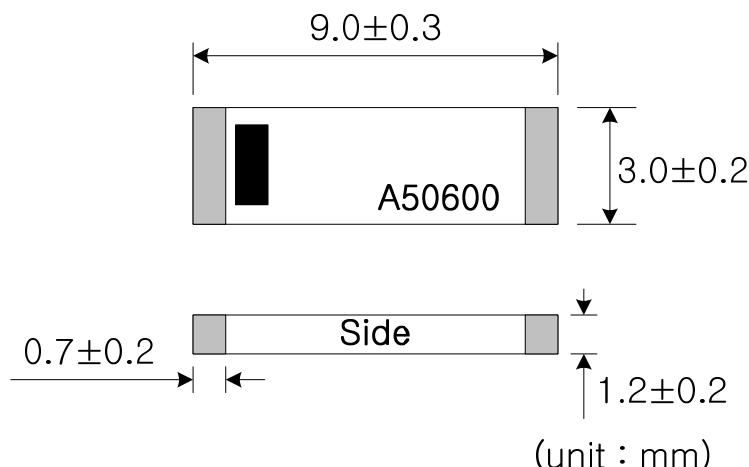
[VSWR : measured on manual jig]



[Radiation Gain : Measured on Ref. Board]

2.2 Mechanical specifications

No	Item	Spec.		Unit
1	Dimensions	W	9.0 \pm 0.3	mm
		D	3.0 \pm 0.2	
		H	1.2 \pm 0.2	
2	Unit Weight	97 \pm 9		mg
3	Operation Temp.	-30 ~ +70		°C
4	Storage Temp.	-40 ~ +85		°C



[Chip Antenna dimension]

2.3 Index method of Part No. & Lot No.

Part No.	<u>ALA</u> (1)	931 (2)	C5 (3)
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- (1) : Amotech Antenna
- (2) : Chip size
- (3) : Version & frequency

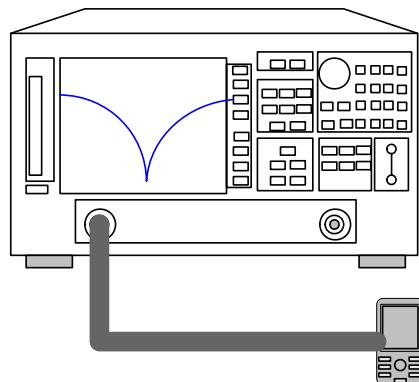
Lot No.	<u>MA</u> (1)	<u>09</u> (2)	<u>A5</u> (3)	<u>0506</u> (4)	<u>01</u> (5)
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- (1) : Mass product Antenna
- (2) : Chip size
- (3) : Version & frequency
- (4) : Y/M
- (5) : Serial No. of product

3. Test Method

3.1 VSWR

Equipment : Network Analyzer 8753ES

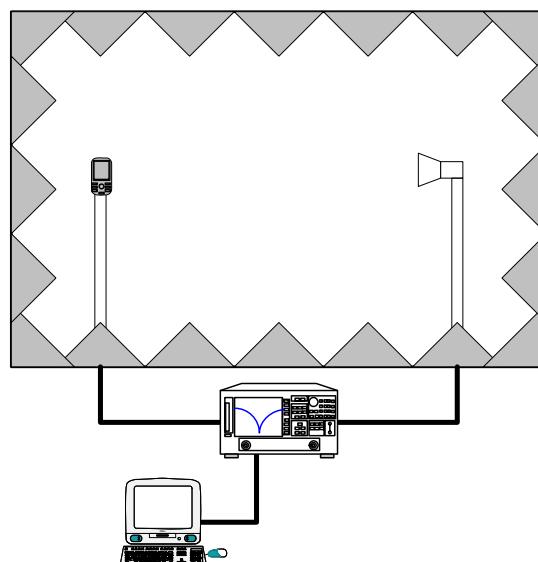


[Test procedure]

- ① Setup as shown picture.
- ② Calibrate Network Analyzer in frequency range of $f_0 \pm 400$ MHz, verify that the value of return loss(S_{11}) is under -55 dB with termination(50ohm)
- ③ After connect a mobile set or manual jig for single chip antenna to Network Analyzer, measure the max. value of VSWR in frequency range of spec.

3.2 Radiation gain

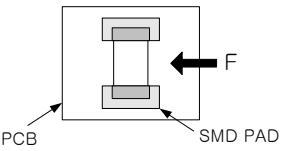
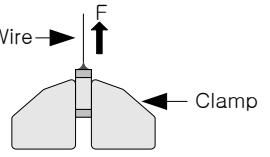
Equipment : Anechoic chamber , Network Analyzer 8753ES



[Test procedure]

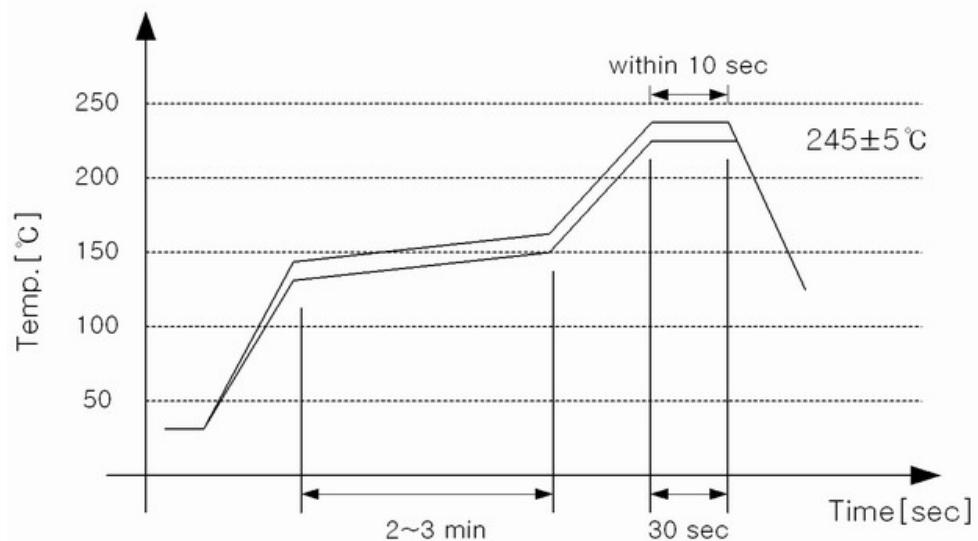
- ① Calibrate network analyzer and anechoic chamber using reference horn antenna.
- ② Set-up operation software (frequency, angle step, etc.)
- ③ After connecting AUT on holder, measure radiation gain.

4. Reliability Test

NO	ITEM	TEST CONDITION	TEST REQUIREMENTS
1	Adhesive Strength of Termination	<p>1. Applied force on SMD chip till detached point from PCB.</p> 	<p>1. No mechanical damage by forces applied on the right. 2. Strength (F) > 7 kgf</p>
2	Tensile Strength	<p>1. Wire : 0.6~0.8 tined Cu wire</p> 	<p>1. No mechanical damage by forces applied on the right. 2. Strength (F) > 3 kgf</p>
3	Thermal Shock (Temperature Cycle)	<p>1. 1 cycle / step 1 : $-40 \pm 3^\circ\text{C}$, 30 min step 2 : $+125 \pm 3^\circ\text{C}$, 30 min 2. Number of cycle : 30 3. Measure after left for 48 hrs min. at room temperature</p>	<p>1. No visual damage 2. Within electric spec (VSWR)</p>
4	High Temperature Resistance	<p>1. Temperature : $+125 \pm 5^\circ\text{C}$ 2. Time : 1000 ± 24 hrs 3. Measure f_C after left for 24 hrs min. at room temperature</p>	<p>1. No visual damage 2. Within electric spec (VSWR)</p>
5	Low Temperature Resistance	<p>1. Temperature : $-40 \pm 5^\circ\text{C}$ 2. Time : 1000 ± 24 hrs 3. Measure f_C after left for 48 hrs min. at room temperature</p>	<p>1. No visual damage 2. Within electric spec (VSWR)</p>
6	Humidity (Steady Condition)	<p>1. Humidity : 85 % RH 1. Temperature : $+85 \pm 3^\circ\text{C}$ 2. Time : 1000 ± 24 hrs 3. Measure f_C after left for 48 hrs min. at room temperature</p>	<p>1. No visual damage 2. Within electric spec (VSWR)</p>

5. Soldering Recommend

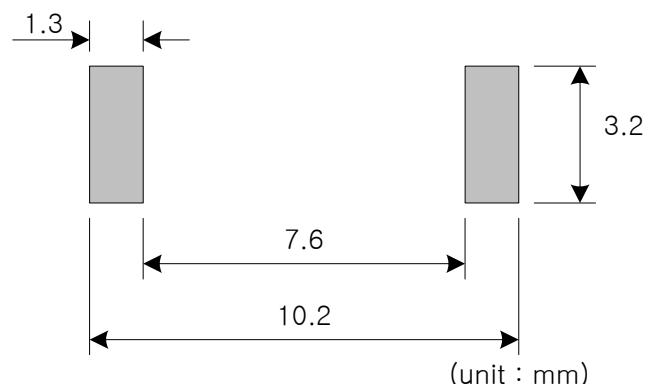
5.1 Reflow profile for Pb-free



This product is designed for reflow soldering only. Do not use flow (wave) soldering.

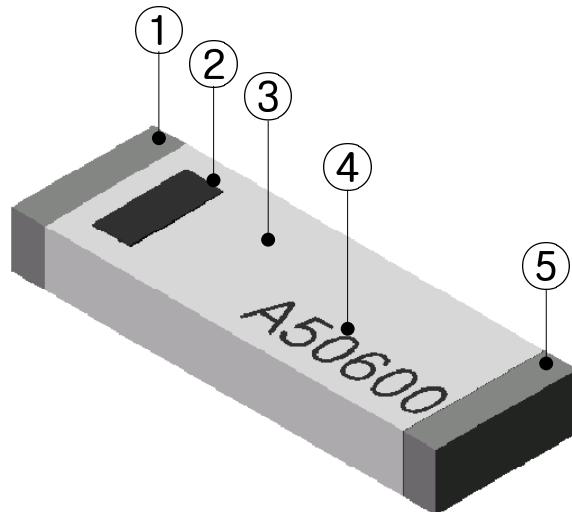
- ① Use non-activated flux (Cl content 0.2% max.)
- ② Follow the recommended soldering conditions to avoid damage.
- ③ Reflow-cycle is max. 3 times.

5.2 PCB land pattern



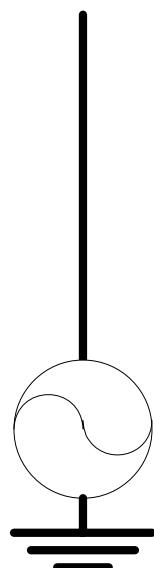
6. Structure and Material

6.1 Material



No	Part	Function	Material
1	External Electrode	Soldering, Feeding	Ag/Ni/Sn
2	Direction Index	Feeding Index	Ceramic
3	Ceramic Body	-	Ceramic
4	Text	Part No. Index	Ceramic
5	External Electrode	Soldering	Ag/Ni/Sn

6.2 Equivalent symbol

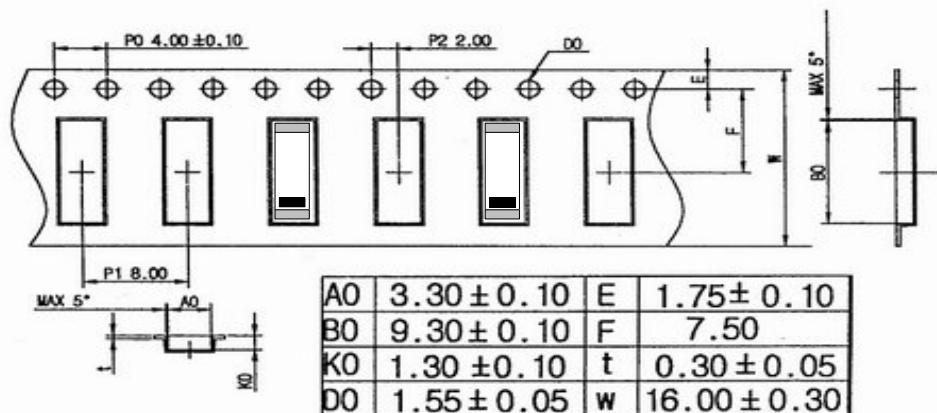


7. Cautions

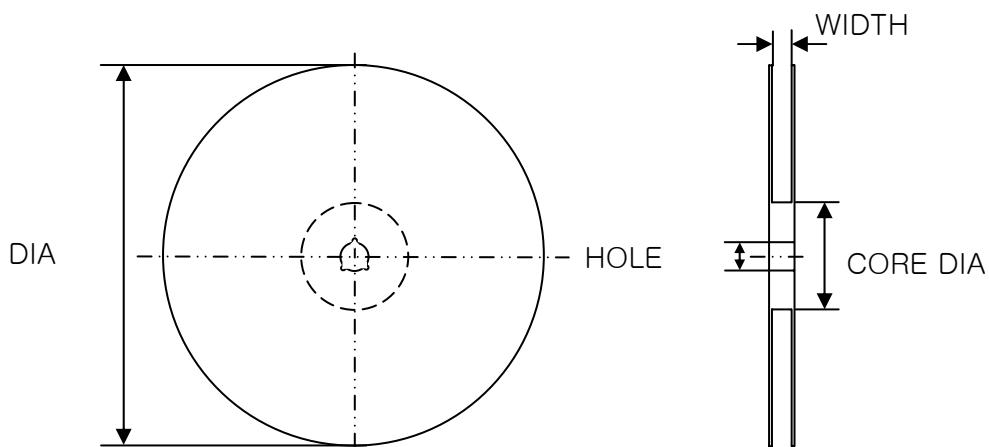
- ① Storage environment must be at ambient temperature of 15~35°C and ambient humidity of 45~75 % RH. (MSL Level 2)
- ② Chip antenna can experience degradation of termination solder ability when subjected to high temperature of humidity, or if exposed to sulfur or chlorine gases.
- ③ Avoid mechanical shock (ex. falling) to the chip antenna to prevent mechanical cracking inside of the ceramic dielectric due to its own weight.

8. Packing Method

8.1 Carrier-tape



8.2 Reel



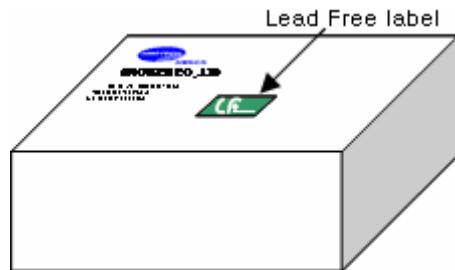
item	DIA	WIDTH	CORE DIA	HOLE
dimension(mm)	180.0 ± 0.3	17.0 ± 0.3	60.0 ± 1	13.0 ± 0.5

8.3 Packing box

8.3.1 Small box

Size : 185 (W) x 185 (D) x 68 (H) (mm)

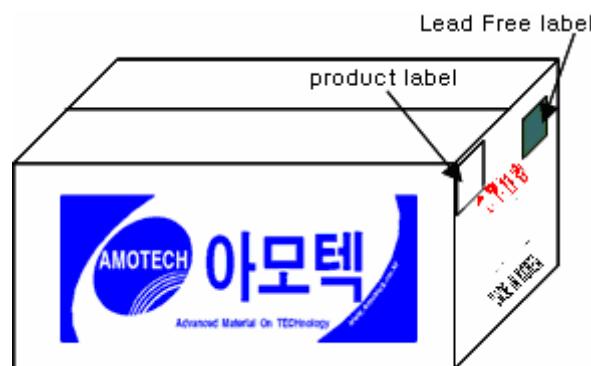
Q'TY : 3 reel (1,000 ea/reel × 3 reel = 3,000 ea)



8.3.2 Middle box

Size : 365 (W) x 200 (D) x 200 (H) (mm)

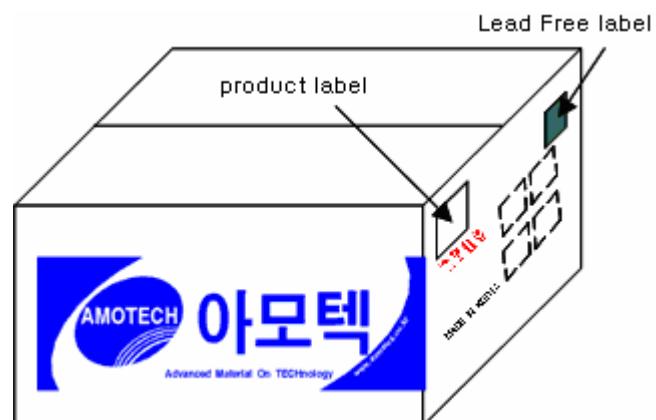
Q'TY : 5 small box(3,000 ea/small box × 5 small box = 15,000 ea)



8.3.3 Large box

Size : 390 (W) x 390 (D) x 280 (H) (mm)

Q'TY : 14 small box(3,000 ea/ small box × 14 small box = 42,000 ea)



9. Manufacture and Place

9.1 Manufacture

Amotech Co., Ltd

9.2 Place

5B 1L, Namdong Industrial Complex, 617 Namchondong, Namdonggu,
Incheon, Korea

To: AMOTECH CO., LTD.5BL-1L, 617
Namchon-dong
Namdong-gu
INCHEON 405-100
Korea

The following merchandise was submitted and identified by the client as :

Commodity : Multilayer Chip Antenna**SGS File No.** : GP06-24480**Received Date** : September 18, 2006**Test Performing Date** : September 19, 2006**Test Performed** : SGS Testing Korea tested the sample(s) selected by applicant with following results**Test Results** : For further details, please refer to following page(s)**SGS Testing Korea Co. Ltd.**

Jade Jang
Monet Jeong
Jully Oh
Jerry Jung
/Testing Person

**Jeff Jang / Chemical Lab Mgr**



Test Report No. F690501/LF-CTSGP06-24480

Date: September 25, 2006

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Sample No. : GP06-24480.001

Sample Description : Multilayer Chip Antenna

Style/Item No. : Multilayer Chip Antenna

Heavy Metals

Test Items	Unit	Test Method	MDL	Results
Cadmium (Cd)	mg/kg	US EPA 3050B(1996), US EPA 6010B(1996), ICP	0.5	N.D.
Lead (Pb)	mg/kg	US EPA 3050B(1996), US EPA 6010B(1996), ICP	5	N.D.
Mercury (Hg)	mg/kg	US EPA 3052(1996), US EPA 6010B(1996), ICP	2	N.D.
Hexavalent Chromium (Cr VI)	mg/kg	US EPA 3060A(1996), US EPA 7196A(1992), UV	1	N.D.

Flame Retardants-PBBs/PBDEs

Test Items	Unit	Test Method	MDL	Results
Monobromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Dibromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tribromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tetrabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Pentabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Hexabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Heptabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Octabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Nonabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Decabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Monobromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Dibromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tribromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tetrabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Pentabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Hexabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Heptabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Octabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Nonabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Decabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.

NOTE: (1) N.D. = Not detected.(<MDL)

(2) ppm = mg/kg

(3) MDL = Method Detection Limit

(4) - = No regulation

(5) ** = Qualitative analysis (No Unit)

(6) Negative = Undetectable / Positive = Detectable

Picture of Sample as Received:***** End *****

NOTE: (1) N.D. = Not detected.(<MDL)
(2) ppm = mg/kg
(3) MDL = Method Detection Limit
(4) - = No regulation
(5) ** = Qualitative analysis (No Unit)
(6) Negative = Undetectable / Positive = Detectable